

Notice of References Cited	Application/Control No. 10/567,629		Applicant(s)/Patent Under Reexamination VADDE ET AL.	
	Examiner JASON M. PERILLA		Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,831,479 A	11-1998	Leffel et al.	330/124D
*	B	US-5,834,975 A	11-1998	Bartlett et al.	330/278
*	C	US-6,137,355 A	10-2000	Sevic et al.	330/51
*	D	US-6,255,906 B1	07-2001	Eidson et al.	330/124R
*	E	US-6,463,269 B2	10-2002	DeMarco, Anthony Thomas	455/341
*	F	US-2003/0132800 A1	07-2003	Kenington, Peter	330/124.00R
*	G	US-7,119,621 B2	10-2006	Chen et al.	330/295
*	H	US-7,151,913 B2	12-2006	Ahmed, Walid Khairy Mohamed	455/91
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.